

11046 U.S. PRO
10/001375



U.S. UTILITY Patent Application

PATENT NUMBER and
ISSUE DATE

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10003375	11/15/2001	324	765,000	2923 2862	Nguyen, Tung

**APPLICANTS: Ong Adrian; Engelkemier Darren; Sprague Edward; Miller Alan;
Shirahata Takehiko;

**CONTINUING DATA VERIFIED:

THIS APPLN CLAIMS BENEFIT OF 60/279,416 03/28/2001
WHICH IS A CON OF 09/384,791 08/26/1999 PAT 6,195,237

** FOREIGN APPLICATIONS VERIFIED:

ITALY MI2000A 002318 10/26/2000

PG-PUB	DO NOT PUBLISH <input checked="" type="checkbox"/>	RESCIND <input type="checkbox"/>	
Foreign priority claimed	<input type="checkbox"/> yes <input type="checkbox"/> no	ATTORNEY DOCKET NO	
35 USC 119 conditions met	<input type="checkbox"/> yes <input type="checkbox"/> no	M-9433 US	
Certified and Acknowledged Examiner's initials		TITLE: Layout and use of bond pads and probe pads for testing of integrated circuit devices	
		U.S. DEPT. OF COM/USPTO-12/94	

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
		Total Claims	Print Claim for O.G.
Assistant Examiner			
Primary Examiner		DRAWING	
PREPARED FOR ISSUE		Sheets Drawg.	Fig. Drawg.
Application Examiner		Print Fig.	
WARNING: The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368. Possession outside the U.S. Patent & Trademark Office is restricted to authorized employees and contractors only.			
TERMINAL		FILED WITH: <input type="checkbox"/> DISK (CRF) <input type="checkbox"/> CD-ROM (Attached in pocket on right inside flap)	
DISCLAIMER			

FILED WITH:

DISK (CRF)

CD-ROM